

SLOVENSKI STANDARD SIST-TS CEN ISO/TS 17450-1:2008

01-april-2008

GdYV][Z]_UV][/U[Yca Yhf]/g_]\`jY`]]b`]nXY`_U'!`CgbcjY`!`%'XY`.`AcXY`nU'[Yca Yhf]/g_c gdYV][Z]_UV][/c`]b`dfYg_iýUb^Y`fbGC#HG`%+()\$!%&\$\$)と

Geometrical product specifications (GPS) - General concepts - Part 1: Model for geometrical specification and verification (ISO/TS 17450-1:2005)

Geometrische Produktspezifikation (GPS) - Grundlagen - Teil 1: Modell für die geometrische Spezifikation und Prüfung (ISO/TS 17450-1:2005)

Spécification géométrique des produits (GPS) - Concepts généraux - Partie 1: Modele pour la spécification et la vérification géométriques (ISO/TS 17450-1:2005)

Ta slovenski standard je istoveten z: CEN ISO/TS 17450-1:2007

<u>ICS:</u>

17.040.01 Linearne in kotne meritve na Linear and angular splošno measurements in general

SIST-TS CEN ISO/TS 17450-1:2008 en,fr

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST-TS CEN ISO/TS 17450-1:2008</u> https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

TECHNICAL SPECIFICATION SPÉCIFICATION TECHNIQUE TECHNISCHE SPEZIFIKATION

CEN ISO/TS 17450-1

December 2007

ICS 17.040.01

English Version

Geometrical product specifications (GPS) - General concepts -Part 1: Model for geometrical specification and verification (ISO/TS 17450-1:2005)

Spécification géométrique des produits (GPS) - Concepts généraux - Partie 1: Modèle pour la spécification et la vérification géométriques (ISO/TS 17450-1:2005) Geometrische Produktspezifikation (GPS) - Grundlagen -Teil 1: Modell für die geometrische Spezifikation und Prüfung (ISO/TS 17450-1:2005)

This Technical Specification (CEN/TS) was approved by CEN on 8 October 2007 for provisional application.

The period of validity of this CEN/TS is limited initially to three years. After two years the members of CEN will be requested to submit their comments, particularly on the question whether the CEN/TS can be converted into a European Standard.

CEN members are required to announce the existence of this CEN/TS in the same way as for an EN and to make the CEN/TS available promptly at national level in an appropriate form. It is permissible to keep conflicting national standards in force (in parallel to the CEN/TS) until the final decision about the possible conversion of the CEN/TS into an EN is reached.

CEN members are the national standards bodies of Austria, Belgium, Bulgaria, Cyprus, Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovakia, Slovenia, Spain, Sweden, Switzerland and United Kingdom 08

https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008



EUROPEAN COMMITTEE FOR STANDARDIZATION COMITÉ EUROPÉEN DE NORMALISATION EUROPÄISCHES KOMITEE FÜR NORMUNG

Management Centre: rue de Stassart, 36 B-1050 Brussels

Ref. No. CEN ISO/TS 17450-1:2007: E

CEN ISO/TS 17450-1:2007 (E)

Contents

Page

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST-TS CEN ISO/TS 17450-1:2008</u> https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

Foreword

The text of ISO/TS 17450-1:2005 has been prepared by Technical Committee ISO/TC 213 "Dimensional and geometrical product specifications and verification" of the International Organization for Standardization (ISO) and has been taken over as CEN ISO/TS 17450-1:2007 by Technical Committee CEN/TC 290 "Dimensional and geometrical product specification and verification" the secretariat of which is held by AFNOR.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CEN [and/or CENELEC] shall not be held responsible for identifying any or all such patent rights.

According to the CEN/CENELEC Internal Regulations, the national standards organizations of the following countries are bound to announce this Technical Specification: Austria, Belgium, Bulgaria, Cyprus, Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

Endorsement notice

The text of ISO/TS 17450-1:2005 has been approved by CEN as a CEN ISO/TS 17450-1:2007 without any modification.

(standards.iteh.ai)

SIST-TS CEN ISO/TS 17450-1:2008 https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST-TS CEN ISO/TS 17450-1:2008 https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

TECHNICAL SPECIFICATION

ISO/TS 17450-1

First edition 2005-02-01

Geometrical product specifications (GPS) — General concepts —

Part 1:

Model for geometrical specification and verification

iTeh STANDARD PREVIEW Spécification géométrique des produits (GPS) — Concepts généraux —

Partie 1: Modèle pour la spécification et la vérification géométriques

<u>SIST-TS CEN ISO/TS 17450-1:2008</u> https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008



Reference number ISOTS 17450-1:2005(E)

ISO/TS 17450-1:2005(E)

PDF disclaimer

This PDF file may contain embedded typefaces. In accordance with Adobe's licensing policy, this file may be printed or viewed but shall not be edited unless the typefaces which are embedded are licensed to and installed on the computer performing the editing. In downloading this file, parties accept therein the responsibility of not infringing Adobe's licensing policy. The ISO Central Secretariat accepts no liability in this area.

Adobe is a trademark of Adobe Systems Incorporated.

Details of the software products used to create this PDF file can be found in the General Info relative to the file; the PDF-creation parameters were optimized for printing. Every care has been taken to ensure that the file is suitable for use by ISO member bodies. In the unlikely event that a problem relating to it is found, please inform the Central Secretariat at the address given below.

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST-TS CEN ISO/TS 17450-1:2008</u> https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

© ISO 2005

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office Case postale 56 • CH-1211 Geneva 20 Tel. + 41 22 749 01 11 Fax + 41 22 749 09 47 E-mail copyright@iso.org Web www.iso.org Published in Switzerland

Contents

Forewo	ord	iv
Introdu	iction	. v
1	Scope	. 1
2	Normative references	. 1
3	Terms and definitions	. 1
4	Application and future prospects	. 5
5	General	. 5
6 6.1 6.2 6.3	Features General Ideal features Non-ideal features	. 7 . 7
7 7.1 7.2 7.3 7.4	Characteristics General Intrinsic characteristics of ideal features Situation characteristics between ideal features Situation characteristics between non-ideal and ideal features	. 9 . 9 10 11
8 8.1 8.2	Operations	12 12 16
9 9.1 9.2 9.3 9.4	https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4- Specification	16 16 17
10	Verification	18
Annex	A (informative) Examples of application to ISO 1101	20
Annex	B (informative) Mathematical symbols and definitions	33
Annex	C (informative) Comparison between tolerancing and metrology	45
Annex	D (informative) Concept diagram for characteristics	47
Annex	E (informative) Relationship to the GPS matrix model	48
Bibliog	raphy	49

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

In other circumstances, particularly when there is an urgent market requirement for such documents, a technical committee may decide to publish other types of normative document:

- an ISO Publicly Available Specification (ISO/PAS) represents an agreement between technical experts in an ISO working group and is accepted for publication if it is approved by more than 50 % of the members of the parent committee casting a vote h STANDARD PREVIEW
- an ISO Technical Specification (ISO/T\$) represents an agreement between the members of a technical committee and is accepted for publication if it is approved by 2/3 of the members of the committee casting a vote.

SIST-TS CEN ISO/TS 17450-1:2008

An ISO/PAS or ISO/TS is reviewed after three years in order to decide whether it will be confirmed for a further three years, revised to become an International Standard, or withdrawn. If the ISO/PAS or ISO/TS is confirmed, it is reviewed again after a further three years, at which time it must either be transformed into an International Standard or be withdrawn.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO/TS 17450-1 was prepared by Technical Committee ISO/TC 213, *Dimensional and geometrical product specifications and verification*.

ISO/TS 17450 consists of the following parts, under the general title *Geometrical product specifications (GPS)* — *General concepts*:

- Part 1: Model for geometrical specification and verification
- Part 2: Basic tenets, specifications, operators and uncertainties

Introduction

This part of ISO/TS 17450 is a Geometrical Product Specification (GPS) document and is to be regarded as a global GPS document (see ISO/TR 14638). It influences all chain links of the chains of standards.

For more detailed information on the relationship of this part of ISO/TS 17450 to other standards and to the GPS matrix model, see annex E.

In a market environment of increased globalization, the exchange of technical product information is of high importance and the need to express unambiguously the geometry of mechanical workpieces of vital urgency. Consequently, codification associated with the macro- and micro-geometry of workpiece specifications must be unambiguous and complete if the functional geometrical variation of parts is to be limited; in addition, the language ought to be applicable to CAX systems.

The aim of ISO/TC 213 is to provide the tools for a global and "top-down" approach to GPS. These tools are the basis of new standards for a common language for geometrical definition, able to be used by design (assemblies and individual workpieces), manufacturing and inspection, including for description of the measurement procedure, regardless of the media (e.g. paper drawing, numerical drawing or exchange file) used. These tools are based on the characteristics of features, as well as on the constraints between the features and on feature operations, used for the creation of different geometrical features.

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST-TS CEN ISO/TS 17450-1:2008</u> https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST-TS CEN ISO/TS 17450-1:2008 https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

Geometrical product specifications (GPS) — General concepts —

Part 1: **Model for geometrical specification and verification**

1 Scope

This part of ISO/TS 17450 provides a model for geometrical specification and verification and defines the corresponding concepts. It also explains the mathematical basis of the concepts associated with the model.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 14660-1:1999, Geometrical Product Specifications (GPS) - Geometrical features — Part 1: General terms and definitions

International Vocabulary of Basic and General Terms in Metrology (VIM). BIPM, IFCC, IEC, ISO, IUPAC, IUPAP, OIML, 2nd edition, 1993 https://standards.iteh.a/catalog/standards/sist/60032fad-ffa8-4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

3 Terms and definitions

For the purposes of the present document, the terms and definitions given in ISO 14660-1 and VIM, and the following apply.

3.1

associated feature

ideal feature established from a non-ideal surface model (skin model) or from a real surface through an association operation

NOTE The relationship between this term and ISO 14660-1 is given in Figure 1.

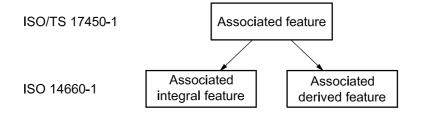


Figure 1 — Relationships of the term associated feature

ISO/TS 17450-1:2005(E)

3.2

association

operation used to fit ideal feature(s) to non-ideal feature(s) according to a criterion

NOTE See 8.1.5.

3.3

bounded feature

feature contained within a sphere of finite radius

3.4

characteristic

single property of one or more feature(s) expressed in linear or angular units

NOTE See annex D.

3.5

collection

operation used to identify more than one feature together, in accordance with the function of the workpiece

NOTE See 8.1.6.

3.6

construction

operation used to build ideal feature(s) from other ideal features, within constraints

NOTE See 8.1.7.

iTeh STANDARD PREVIEW (standards.iteh.ai)

3.7 deviation

difference between the value of a characteristic obtained from the non-ideal surface model (skin model) and the corresponding nominal value https://standards.iteh.ai/catalog/standards/sist/60b32fad-ffa8-4cc0-9de4-

5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

3.8

evaluation

operation used to identify either the value of a characteristic, or its nominal value and its limit(s)

NOTE See 8.2.

3.9

extraction

operation used to identify specific points from a non-ideal feature

NOTE See 8.1.3.

3.10

feature geometric feature

point, line or surface

[ISO 14660-1]

3.11

feature operation specific tool required for obtaining feature

specific tool required for obtaining features

3.12 filtration

operation used to create a non-ideal feature by reducing the level of information of a non-ideal feature

NOTE See 8.1.4.

ISO/TS 17450-1:2005(E)

3.13

ideal feature

feature defined by a parametrized equation

NOTE The expression of the parametrized equation depends on the type of ideal feature and on the intrinsic characteristics.

3.14

intrinsic characteristic

characteristic of an ideal feature

NOTE 1 See 7.2.

NOTE 2 Ideal features have only dimensional characteristics as intrinsic characteristics.

NOTE 3 The intrinsic characteristics are the parameters of the parametrized equation of the ideal feature.

3.15

invariance class

a group of ideal features defined by the same invariance degree

3.16

invariance degree of an ideal feature

displacement(s) of the ideal feature for which the feature is kept identical in the space

NOTE It corresponds to the degree of freedom used in kinematics. REVIEW

3.17

(standards.iteh.ai)

nominal feature

ideal feature independent of the non-ideal surface model (skin model)

NOTE The relationship between this term and ISO g/4660 and given in Figure 2.4cc0-9de4-5c7a726d94f1/sist-ts-cen-iso-ts-17450-1-2008

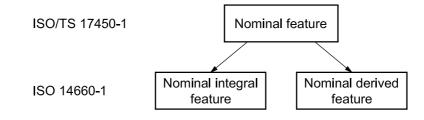


Figure 2 — Relationships of the term nominal feature

3.18

nominal model

model of the workpiece of perfect shape defined by the designer (design intent)

3.19

non-ideal feature

imperfect feature fully dependent on the non-ideal surface model (skin model)

3.20

operation

specific tool required to obtain features or values of characteristics, their nominal value and their limit(s)